(Rev. 2-32)

U.S. Department of Commerce

Patent and Trademark Office

Atty. Docket No. LMPY-9510

Serial No.

Applicant:

Juergen Kleinshmidt

Filed: October 9, 2001 Group: 2881

Information Disclosure Statement by Applicant

(Use several sheets if necessary)

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Page	2	of	7	
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(Rev. 2-32)

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	Info	rmation Disclosure St	atement by A	Applicant	Applica	nt:			
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(Use several sheets if necessary)				Juergen Kleinshmidt Filed: October 9, 2001 Group: 2881					
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